

<b>Notice of References Cited</b>	Application/Control No. 10/801,445	Applicant(s)/Patent Under Reexamination LEE, HWA-JIN	
	Examiner Stephen M. D'Agosta	Art Unit 2683	Page 1 of 1

**U.S. PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
	A	US-2004/0198457 A1	10-2004	Hayashida et al.	455/566
	B	US-6,023,620 A	02-2000	Hansson, Lars	455/419
	C	US-2003/0144024 A1	07-2003	Luo, Chin-Fa	455/551
	D	US-5,128,672 A	07-1992	Kaehler, Edwin B.	341/23
	E	US-4,885,580	12-1989	Noto et al.	341/23
	F	US-6,624,801 B2	09-2003	Moriyama, Hiroaki	345/100
	G	US-2004/0030596 A1	02-2004	Attar et al.	705/14
	H	US-			
	I	US-			
	J	US-			
	K	US-			
	L	US-			
	M	US-			

**FOREIGN PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	O					
	P					
	Q					
	R					
	S					
	T					

**NON-PATENT DOCUMENTS**

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	
	V	
	W	
	X	

\*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)  
Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.